

# **BF494 NPN RF Transistor**





1. Collector 2. Emitter 3. Base

## **Absolute Maximum Ratings \*** T<sub>a</sub> = 25°C unless otherwise noted

Symbol	Parameter	Value	Unit
V <sub>CEO</sub>	Collector-Emitter Voltage	20	V
$V_{CBO}$	Collector-Base Voltage	30	V
V <sub>EBO</sub>	Emitter-Base Voltage	5.0	V
I <sub>C</sub>	Collector Current - Continuous	30 mA	
T <sub>J</sub>	Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature Range	- 55 ~ 150	°C

<sup>\*</sup> These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

### **Thermal Characteristics**

Symbol	Parameter	Value	Unit
$P_{D}$	Total Device Dissipation, by R <sub>θJA</sub> Derate above 25°C	350 2.8	mW mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to case	125	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	357	°C/W

### Electrical Characteristics\* T<sub>C</sub> = 25°C unless otherwise noted

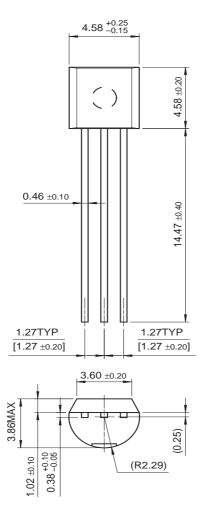
Symbol	Parameter	Conditions	Min.	Max.	Units
V <sub>(BR)CEO</sub>	Collector-Emitter Breakdown Voltage	$I_C = 1.0 \text{mA}, I_B = 0$	20		V
V <sub>(BR)CBO</sub>	Collector-Base BreakdownVoltage	$I_C = 10\mu A, I_E = 0$	30		V
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = 10\mu A, I_C = 0$	5.0		V
I <sub>CES</sub>	Collector-Emitter Sustaining Current	$V_{CE} = 40V, V_{EB} = 0V$		10	nA
h <sub>FE</sub>	DC Current Gain	$V_{CE} = 10V$ , $I_C = 1mA$	67	222	
V <sub>CE</sub> (sat)	Collector-Emitter Saturation Voltage	$I_C = 10$ mA, $I_B = 5$ mA		0.2	V
V <sub>BE</sub> (sat)	Base-Emitter Saturation Voltage	$I_C = 10 \text{mA}, I_B = 5 \text{mA}$		0.92	V
V <sub>BE</sub> (ON)	Base-Emitter On Voltage	V <sub>CE</sub> = 10V, I <sub>C</sub> = 10mA	650	740	mV

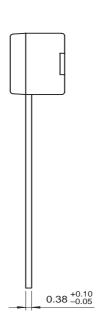
<sup>\*</sup> DC Item are tested by Pulse Test: Pulse Width≤300us, Duty Cycle≤2%

These ratings are based on a maximum junction temperature of 150 degrees C.
 These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations

# **Package Dimensions**

TO-92





Dimensions in Millimeters

UltraFET®

UniFET™

 $VCX^{TM}$ 

Wire™

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